

iNEMI Expanded Beam Connector Project

The logo for FiberQA, featuring the word "FIBER" in red and "QA" in white, with a red crosshair over the "Q". The logo is framed by a blue L-shaped line.

FIBERQA

Study of the Loss Due to Applied Contamination on PRIZM-MT[®] Expanded Beam Lenses

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OFC iNEMI Face to Face Meeting

12 March 2018

Overview

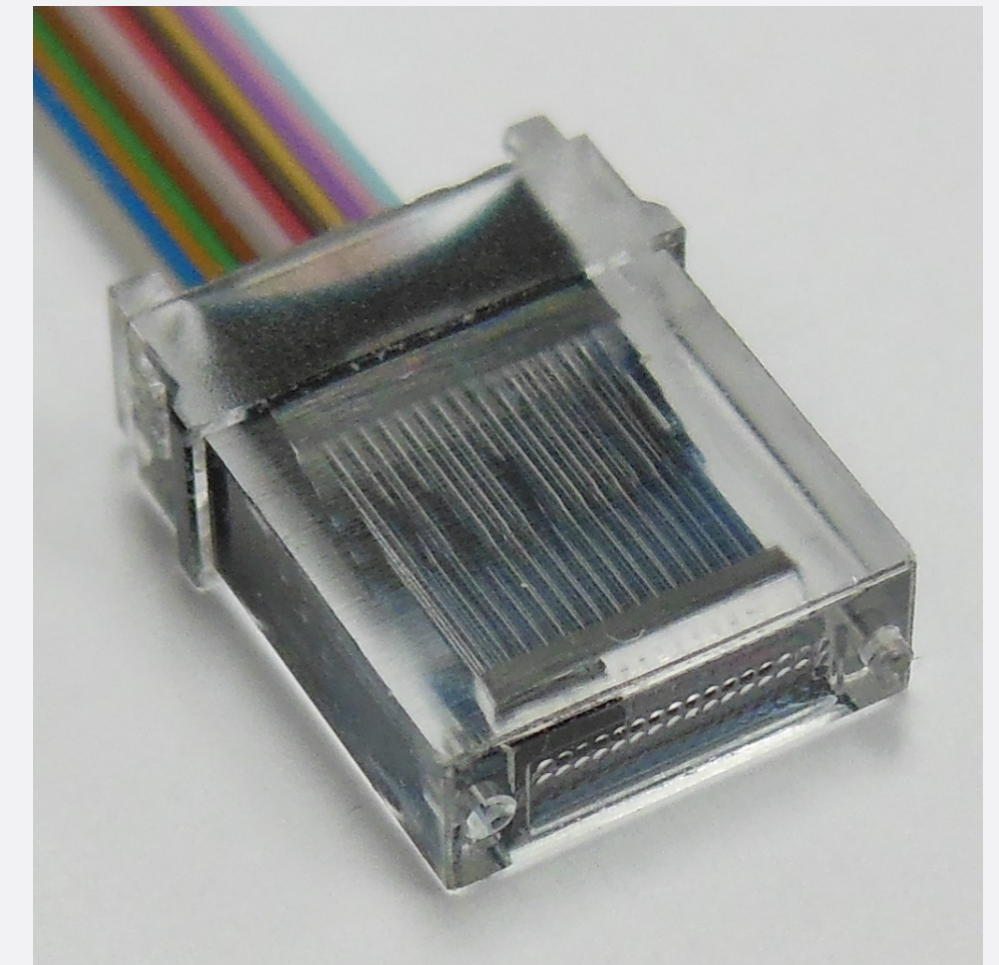
Contaminated Loss Measurements of PRIZM-MT[®] Lensed Connectors

- ✓ Contaminate using Arizona Road Dust
- ✓ Measure difference in Insertion Loss (IL) due to the contamination
- ✓ Capture images of the lens surfaces and process to detect the contamination
- ✓ Compute the loss from detected defect images
- ✓ Compare Measured and Computed IL due to contamination
 - Dr. Michael Kadar-Kallen and Ke Wang will present results in later talks

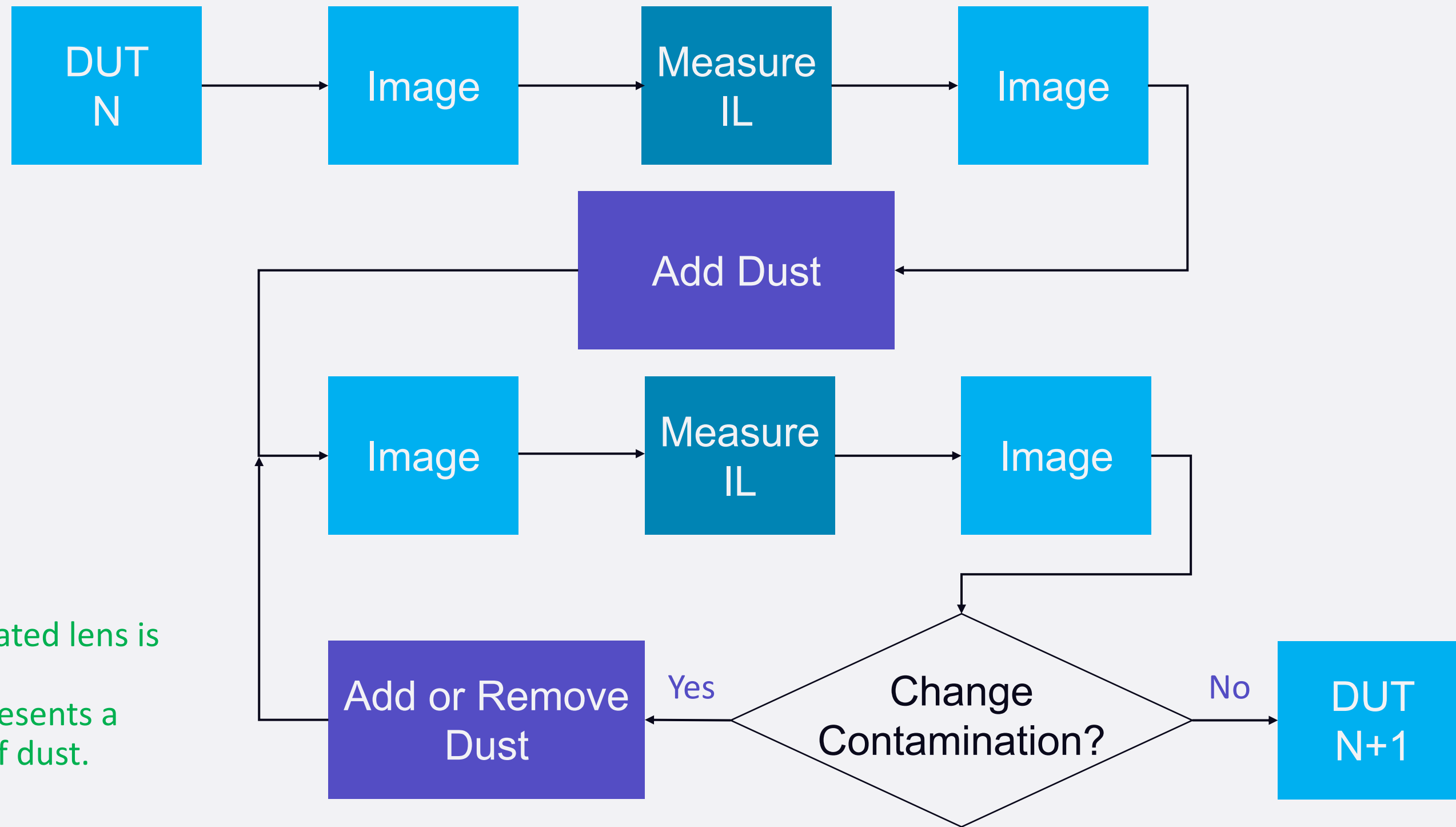
PRIZM-MT Contamination Study

US Conec 26-27 Feb 2018

- ✓ US Conec provided samples (Device Under Test (DUT)) of MXC plugs and facilities for conducting the measurements
- ✓ US Conec personnel measured the IL
- ✓ FiberQA captured and processed the lens images
- ✓ CommScope and US Conec analyzed the data and images



Experiment Flow Chart



Note: each contaminated lens is measured only once. Every data point represents a unique distribution of dust.

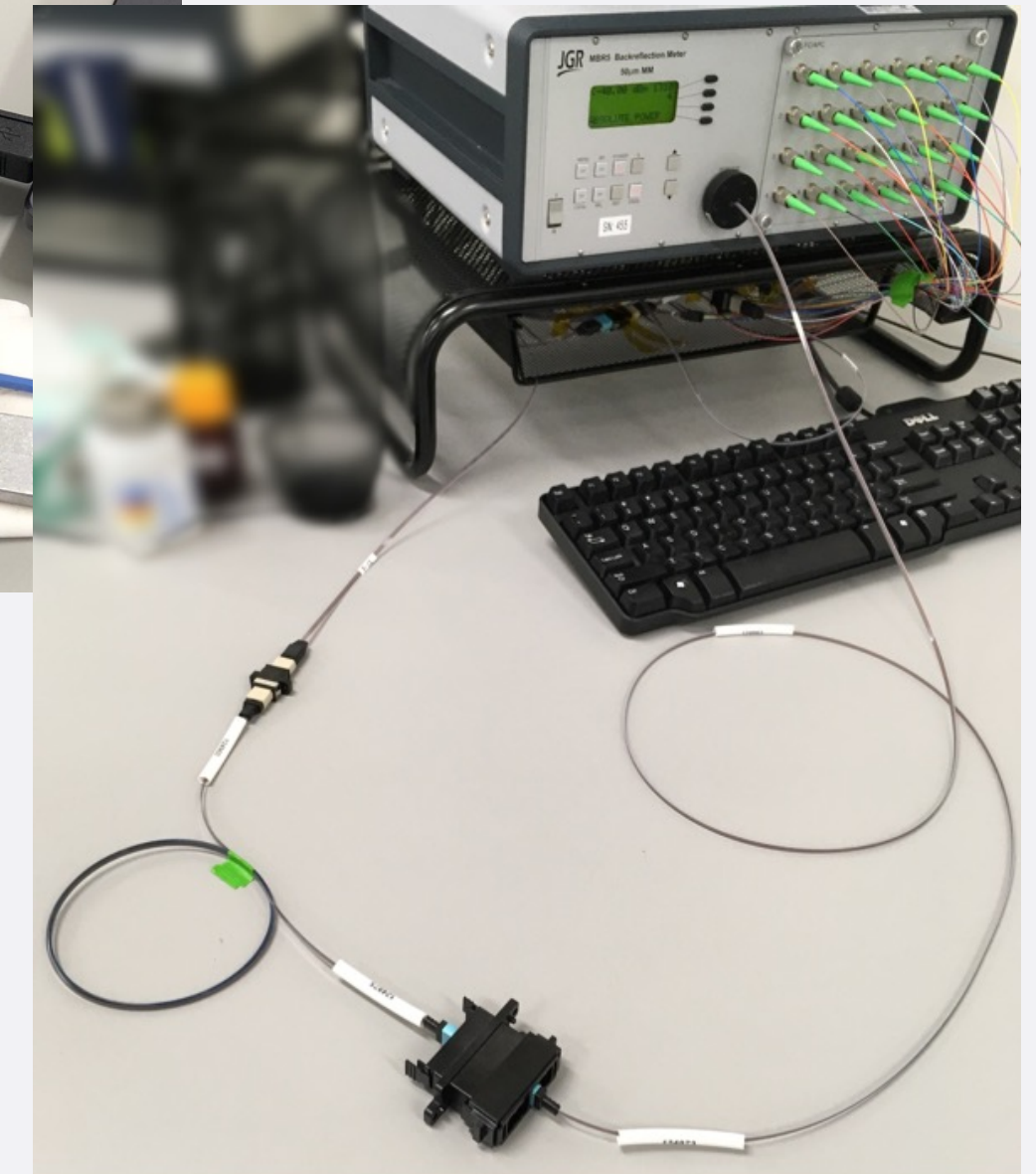
Measurements

Summary of Data Collected

- ✓ Ten (10) DUTs with contamination
- ✓ One DUT with 18 repeats of the same contamination (control sample), ten at beginning and eight at end of the test. Repeats in clean state before contamination as well, both with and without removal from IL setup
- ✓ One DUT kept clean as control sample, measured for IL to establish IL measurement noise
- ✓ Changed contamination on about half of the DUTs to give total of 172 unique lens/contamination level data points
- ✓ IL data collected in clean state for each DUT to establish reference loss

Imaging and IL Equipment

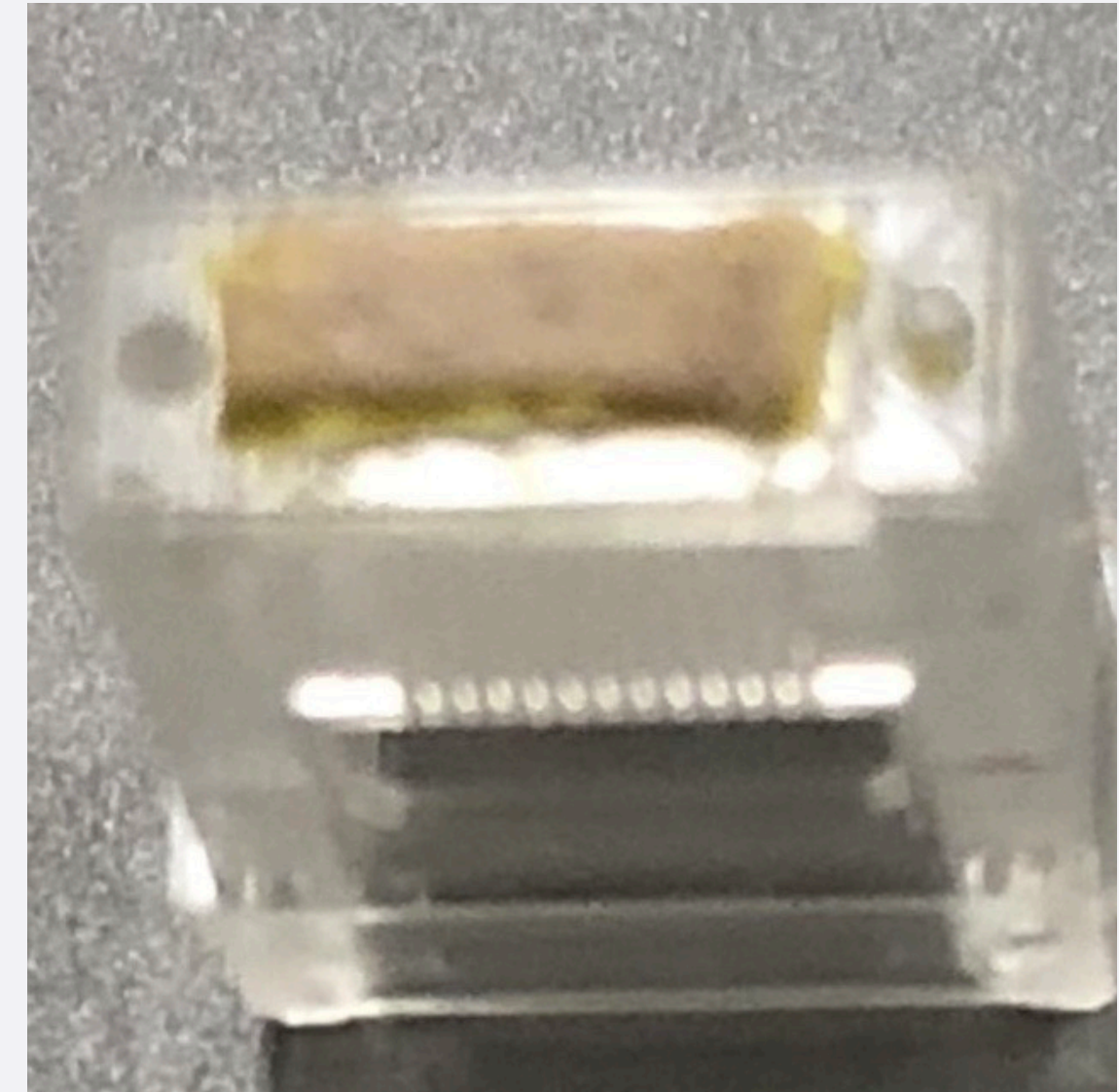
- ✓ Lens images and image processing was conducted using a FastMT-200 from FiberQA
- ✓ IL measurements were made with JGR MBR5 (850 nm)
- ✓ Reference cables and DUTs provided by US Conec



PRIZM-MT Contamination Study

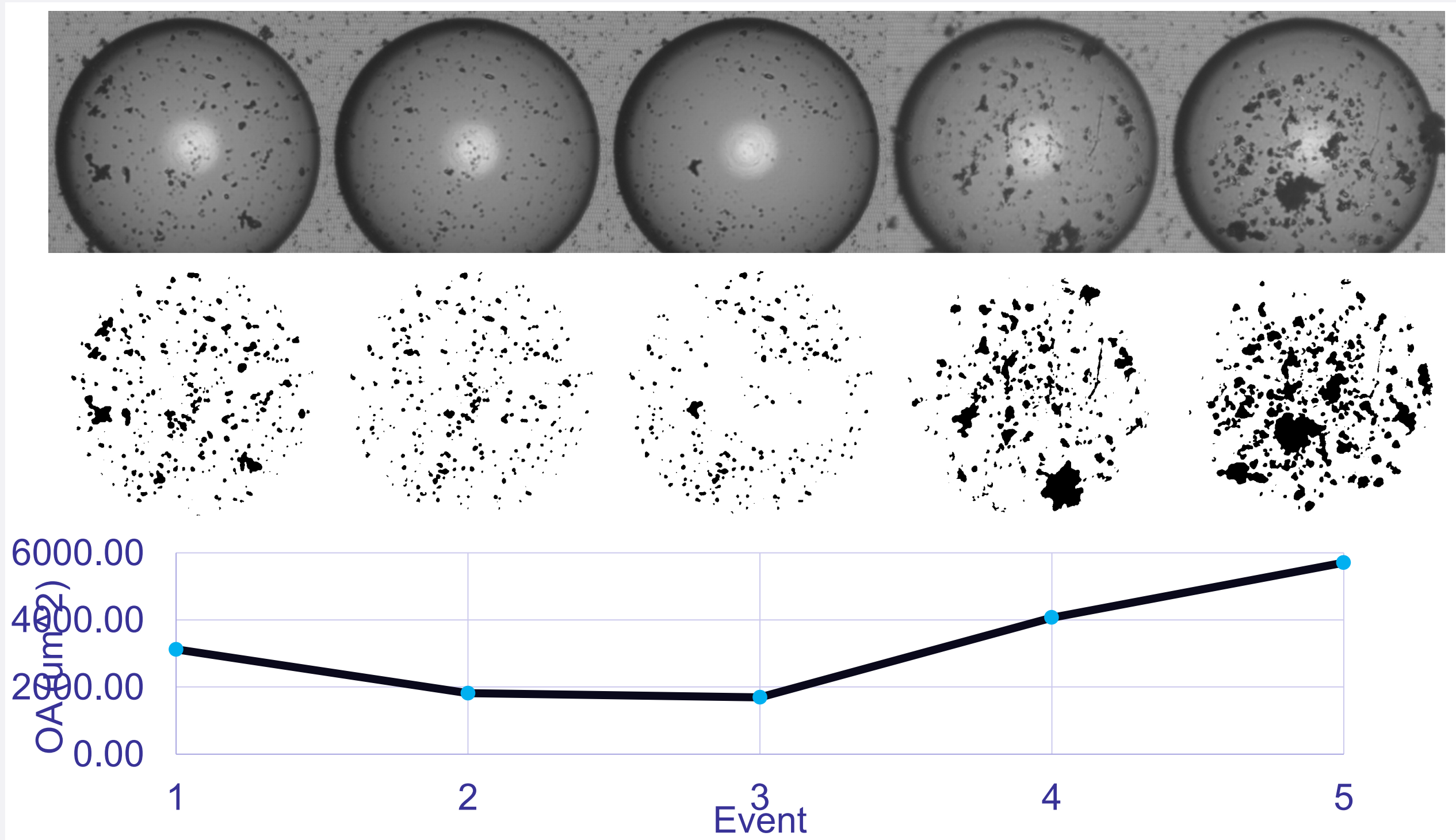
Application Technique

- ✓ Used a Prizm-MT ferrule with thin layer of “putty”. (Great idea Lisa!)
- ✓ Helped avoid contaminating the “pedestal” and pin/hole regions
- ✓ Pressed into coating of Arizona road dust on lint-free cloth
- ✓ Mated with DUT to transfer dust to its end face
- ✓ Used live view of FastMT to evaluate level of contamination
- ✓ Used clean air to reduce level or pressed again to increase level of contamination



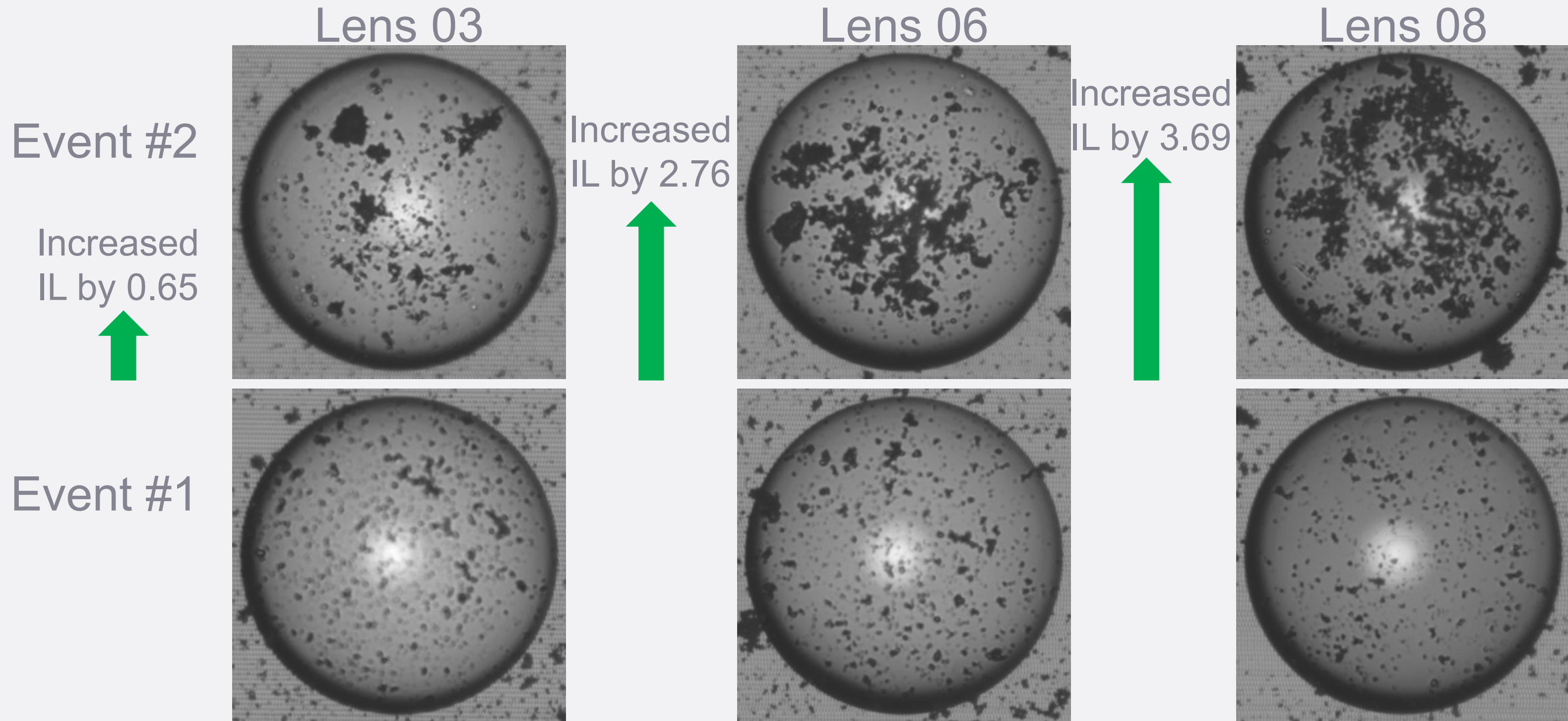
SN124967, Lens 1, Events 1-5

Measured OA with Changing Contamination



SN 124979, Contamination Events 1 and 2

Added contamination between Events



SN 124980

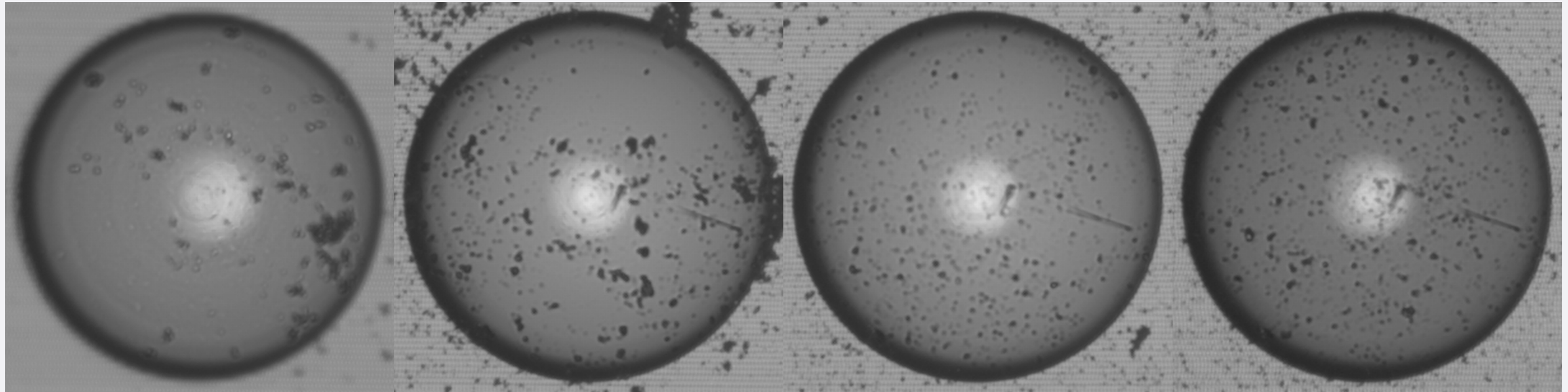
Lens 1, Four Contamination Events

Event #1

Event #2

Event #3

Event #4



OA: 1902

OA: 3238

OA: 2371

OA: 2796

SN 124980

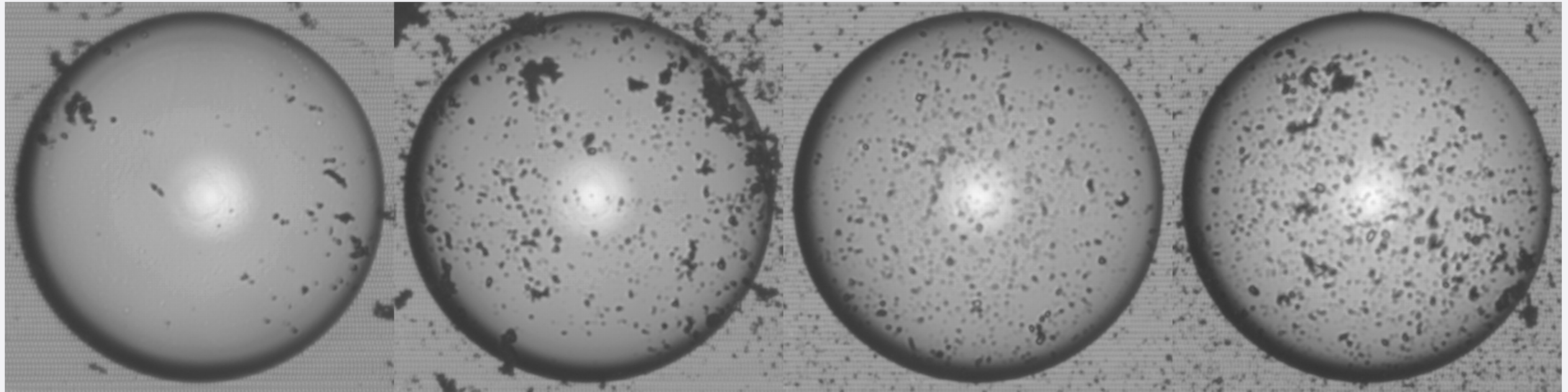
Lens 5, Four Contamination Events

Event #1

Event #2

Event #3

Event #4



OA: 1312

OA: 5849

OA: 4188

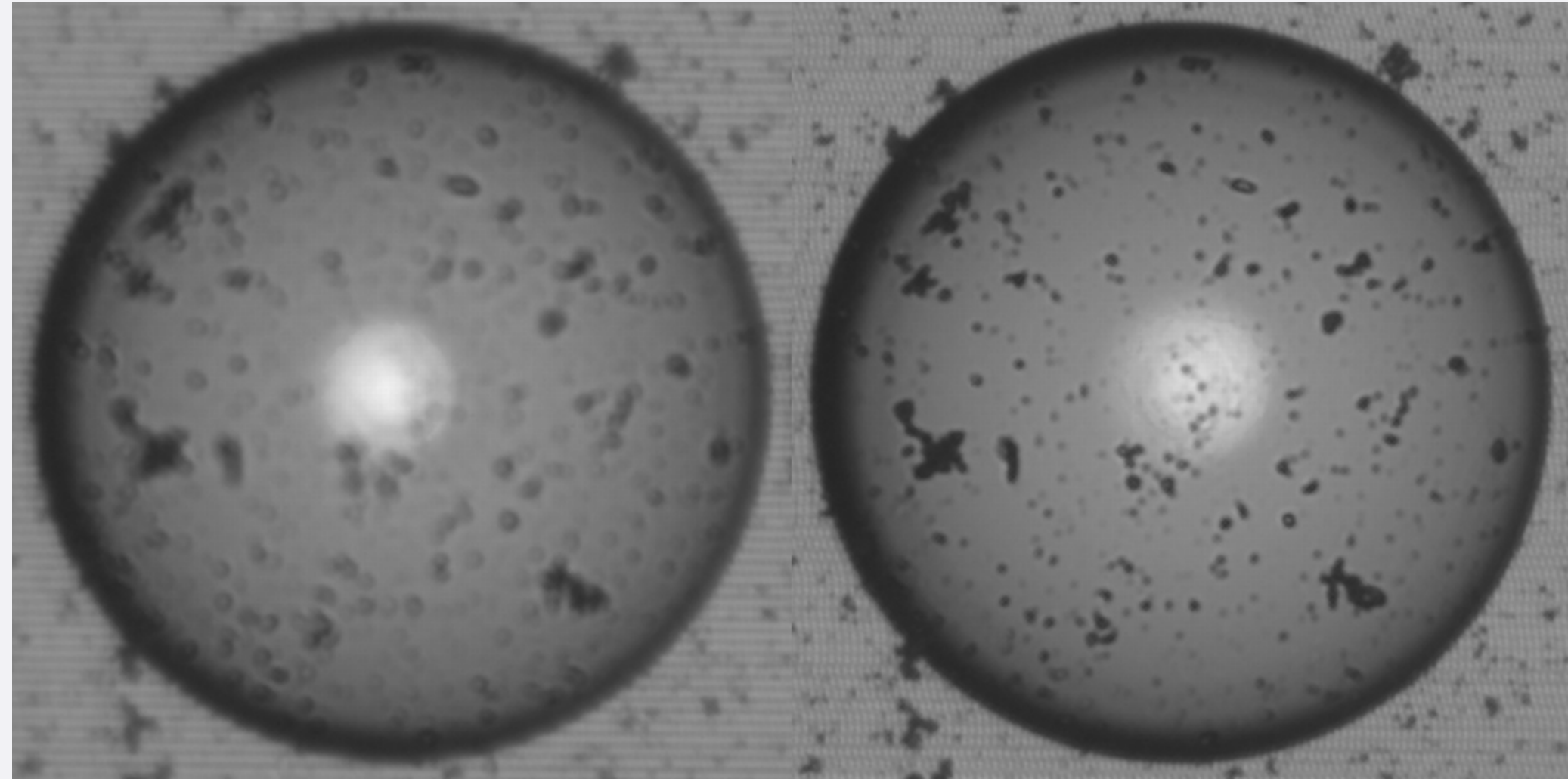
OA: 6331

Focus Issue

- ✓ MXC Shorty plug fit into MXC fixture caused angular misalignments
- ✓ De-focused some lens images
- ✓ Need to evaluate focus for images used in Measured IL comparison
- ✓ In some cases, focus better in either Pre or Post IL images.

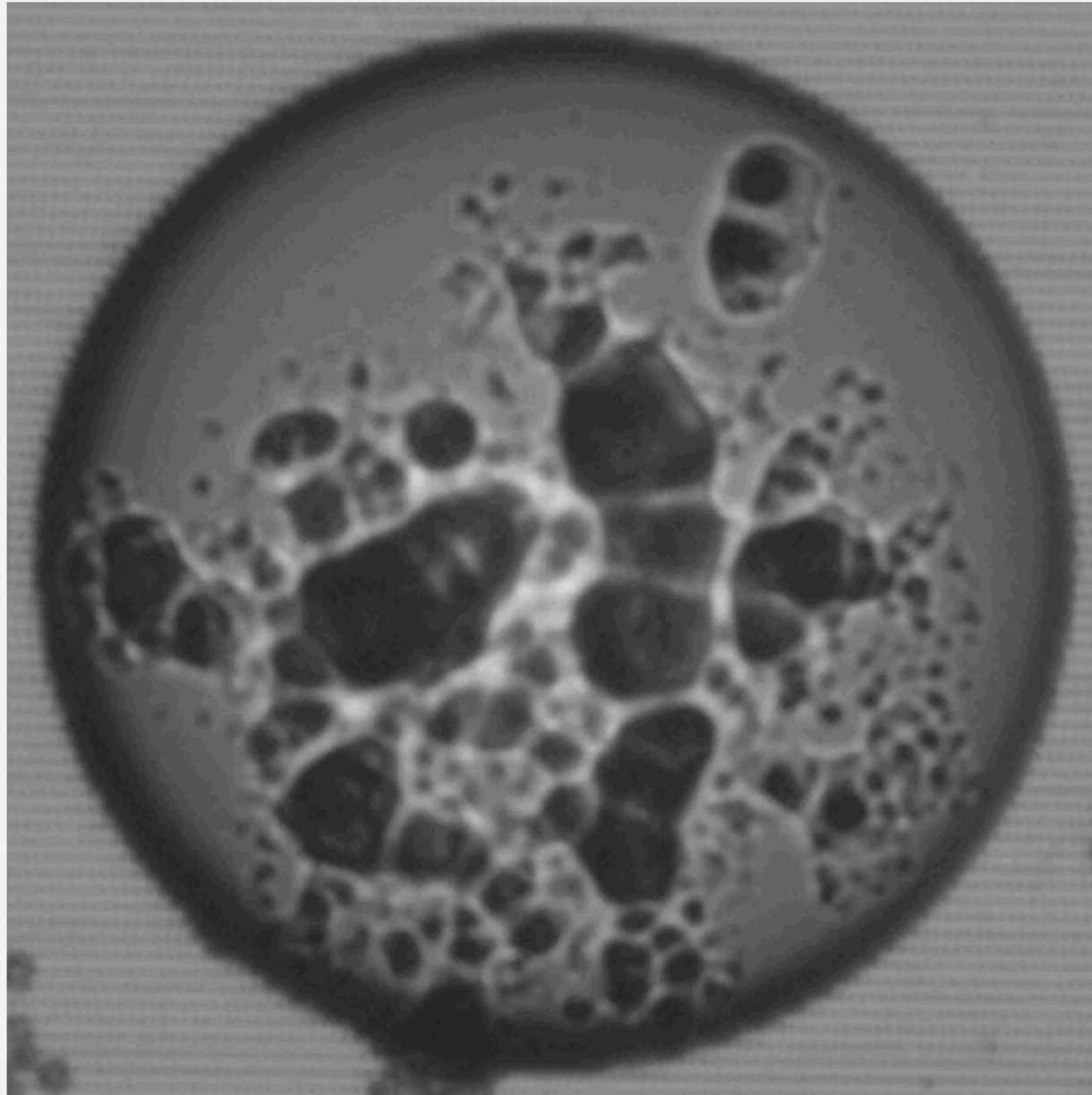
Pre-IL

Post-IL



Contaminated Control Sample

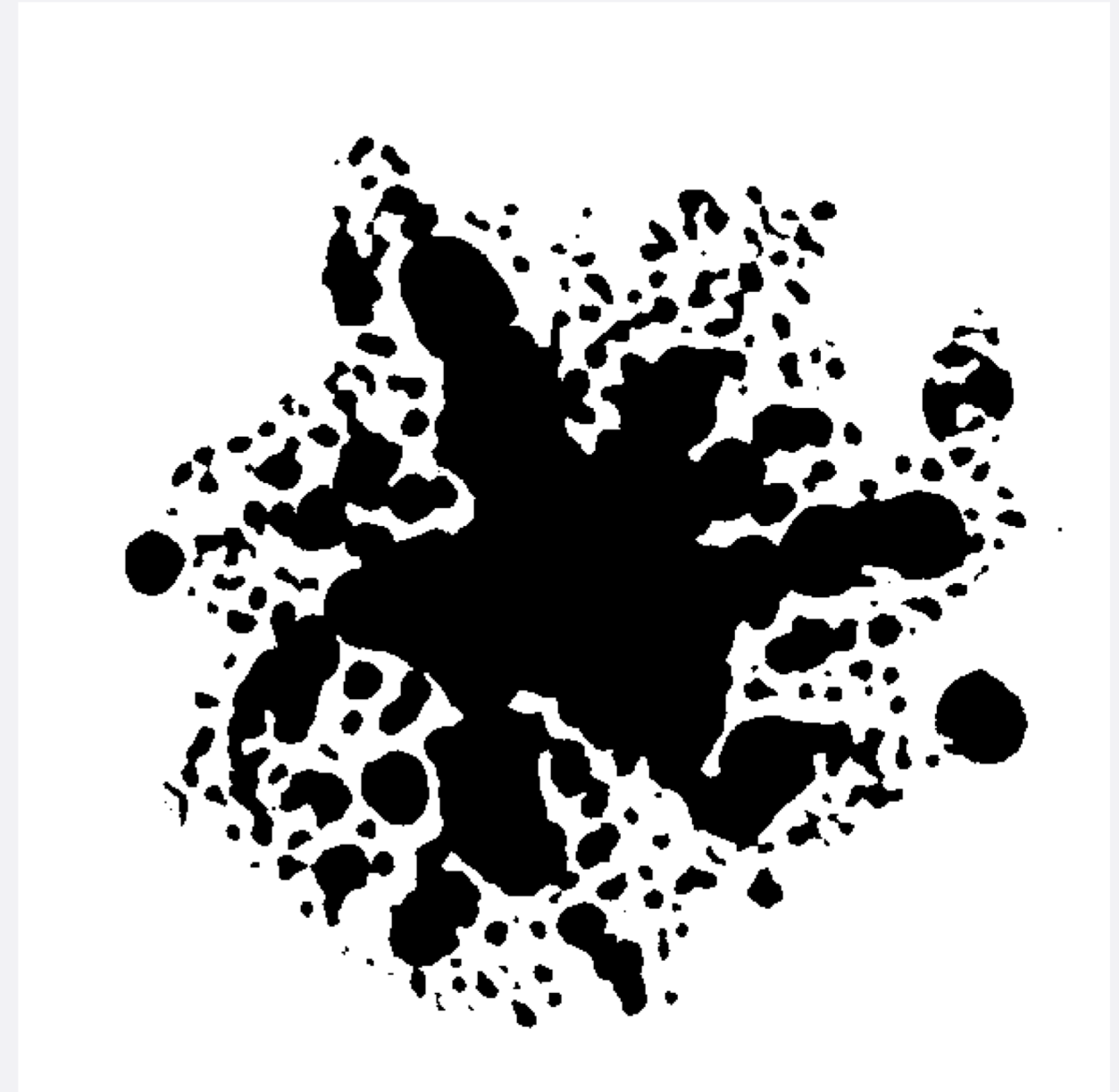
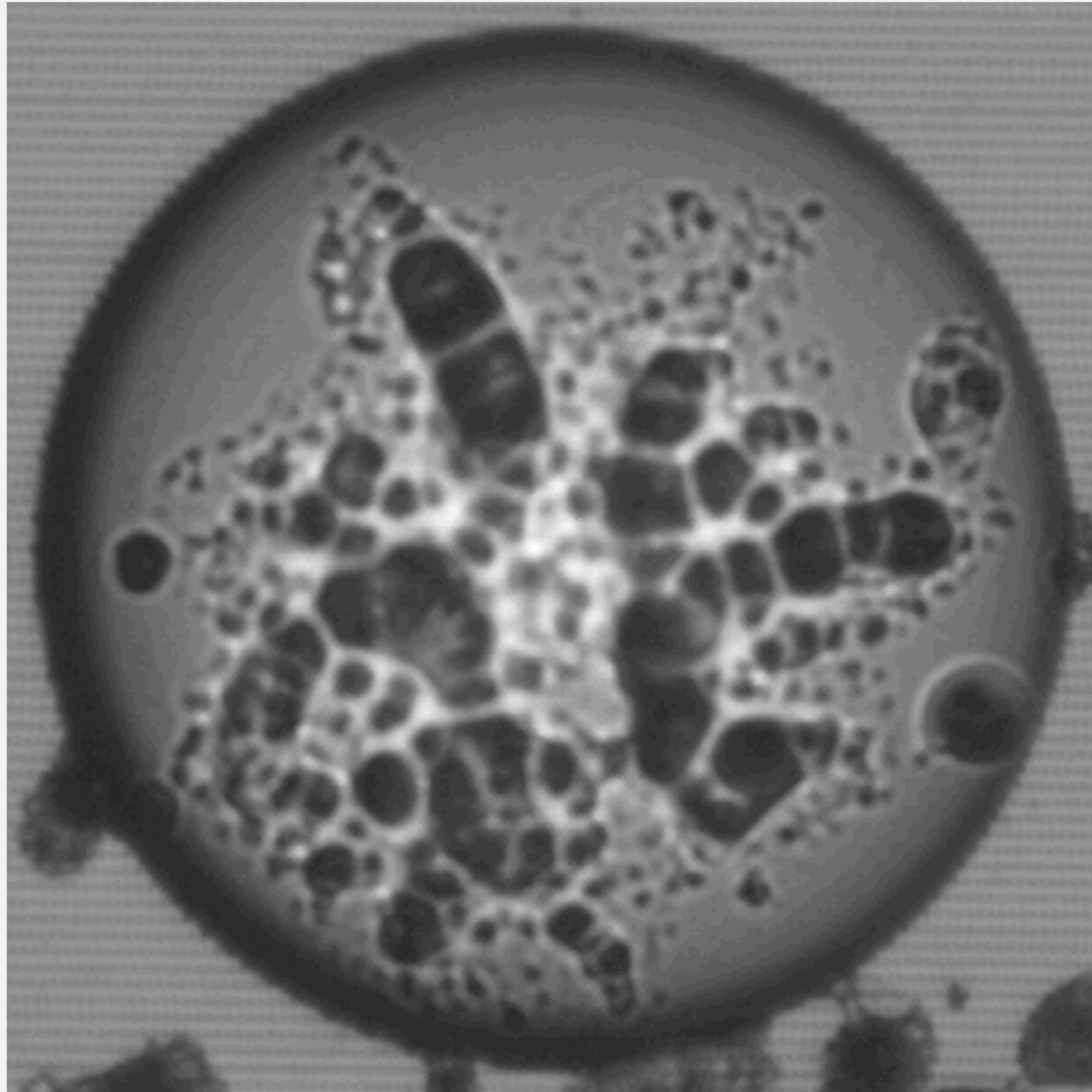
Lens 1, All 18 Repeats



GIFs of all 18 image sets

Contaminated Control Sample

Lens 2, All 18 Repeats



GIFs of all 18 image sets

Summary and Conclusions

- ✓ **Simple contamination method provided samples with Delta IL ranging from 0 to about 6 dB**
 - 144 of 172 (~84%) lens measurement were from 0 to 1 dB
 - Good spread of values from 0 to 1 dB
 - Remaining estimates fairly uniformly spread from 1 to 6 dB
- ✓ **Exact amount and location of contamination varied across lenses, with some having clearer centers than others**
- ✓ **Contamination reduced by cleaning with air or increased by adding contamination, allowing small number of DUTs to provide additional independent contamination events**
- ✓ **Applied contamination was shown to clean off without damage to parts.**

What's Next

Comparison of Measured and Predicted Dust IL

- ✓ **Data Analysis and Preliminary Results: Michael Kadar-Kallen, CommScope**
- ✓ **Expanded Beam Connectors under Dust: Modeling and Measurement: Ke Wang, US Conec**

Acknowledgements

- ✓ US Conec R&D team for samples and collection of the IL data
- ✓ Michael Kadar-Kallen (CommScope) and Ke Wang (US Conec) for comparison of measured and predicted IL using measured contamination images.

「thank you」

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